

**Search Notes**

Application/Control No.

10/607,653

Examiner

Harold Kim

Applicant(s)/Patent under  
Reexamination

OFER ET AL.

Art Unit

2182

**SEARCHED**

Class	Subclass	Date	Examiner
710	45	11/28/2005	HK
707	204, 205	11/28/2005	HK
718	102, 103	11/28/2005	HK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
710	45	11/28/2005	HK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, USPGPUB, JPO, EPO, IEEE, NPL, PLUS, see attached search note; inventor search on eDan	11/28/2005	HK
Consulted AU2182 Primary Examiner Christopher Shin for search	11/23/2005	HK

*Harold Kim 11/28/2005*